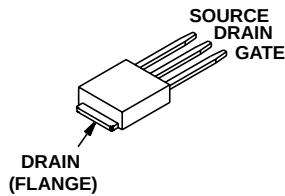


**14A, 150V, 0.150 Ohm, N-Channel,
UltraFET Power MOSFET**

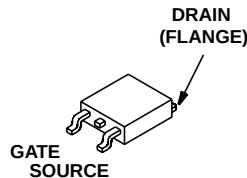
Packaging

JEDEC TO-251AA

JEDEC TO-252AA



HUF75823D3



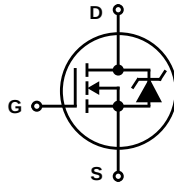
HUF75823D3S



Features

- Ultra Low On-Resistance
 - $r_{DS(ON)} = 0.150\Omega$, $V_{GS} = 10V$
- Simulation Models
 - Temperature Compensated PSPICE™ and SABER® Electrical Models
 - Spice and SABER® Thermal Impedance Models
 - www.intersil.com
- Peak Current vs Pulse Width Curve
- UIS Rating Curve

Symbol



Ordering Information

PART NUMBER	PACKAGE	BRAND
HUF75823D3	TO-251AA	75823D
HUF75823D3S	TO-252AA	75823D

NOTE: When ordering, use the entire part number. Add the suffix T to obtain the variant in tape and reel, e.g., HUF75823D3ST.

Absolute Maximum Ratings $T_C = 25^\circ C$, Unless

Otherwise Specified

	HUF75823D3, HUF75823D3S	UNITS
Drain to Source Voltage (Note 1)	V_{DSS} 150	V
Drain to Gate Voltage ($R_{GS} = 20k\Omega$) (Note 1)	V_{DGR} 150	V
Gate to Source Voltage	V_{GS} ± 20	V
Drain Current		
Continuous ($T_C = 25^\circ C$, $V_{GS} = 10V$) (Figure 2)	I_D 14	A
Continuous ($T_C = 100^\circ C$, $V_{GS} = 10V$) (Figure 2)	I_D 10	A
Pulsed Drain Current	I_{DM} Figure 4	
Pulsed Avalanche Rating	UIS Figures 6, 14, 15	
Power Dissipation	P_D 85	W
Derate Above $25^\circ C$	0.57	W/ $^\circ C$
Operating and Storage Temperature	T_J, T_{STG} -55 to 175	$^\circ C$
Maximum Temperature for Soldering		
Leads at 0.063in (1.6mm) from Case for 10s.	T_L 300	$^\circ C$
Package Body for 10s, See Techbrief TB334.	T_{pkg} 260	$^\circ C$

NOTES:

1. $T_J = 25^\circ C$ to $150^\circ C$.

CAUTION: Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

HUF75823D3, HUF75823D3S

Electrical Specifications $T_C = 25^{\circ}\text{C}$, Unless Otherwise Specified

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNITS	
OFF STATE SPECIFICATIONS							
Drain to Source Breakdown Voltage	BV _{DSS}	I _D = 250μA, V _{GS} = 0V (Figure 11)	150	-	-	V	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 140V, V _{GS} = 0V	-	-	1	μA	
		V _{DS} = 135V, V _{GS} = 0V, T _C = 150 ⁰ C	-	-	250	μA	
Gate to Source Leakage Current	I _{GSS}	V _{GS} = ±20V	-	-	±100	nA	
ON STATE SPECIFICATIONS							
Gate to Source Threshold Voltage	V _{GS(TH)}	V _{GS} = V _{DS} , I _D = 250μA (Figure 10)	2	-	4	V	
Drain to Source On Resistance	r _{DS(ON)}	I _D = 14A, V _{GS} = 10V (Figure 9)	-	0.125	0.150	Ω	
THERMAL SPECIFICATIONS							
Thermal Resistance Junction to Case	R _{θJC}	TO-251 and TO-252	-	-	1.76	⁰ C/W	
Thermal Resistance Junction to Ambient	R _{θJA}		-	-	100	⁰ C/W	
SWITCHING SPECIFICATIONS (V _{GS} = 10V)							
Turn-On Time	t _{ON}	V _{DD} = 75V, I _D = 14A V _{GS} = 10V, R _{GS} = 12Ω (Figures 18, 19)	-	-	48	ns	
Turn-On Delay Time	t _{d(ON)}		-	7.7	-	ns	
Rise Time	t _r		-	24	-	ns	
Turn-Off Delay Time	t _{d(OFF)}		-	45	-	ns	
Fall Time	t _f		-	26	-	ns	
Turn-Off Time	t _{OFF}		-	-	105	ns	
GATE CHARGE SPECIFICATIONS							
Total Gate Charge	Q _{g(TOT)}	V _{GS} = 0V to 20V	V _{DD} = 75V, I _D = 14A, I _{g(REF)} = 1.0mA (Figures 13, 16, 17)	-	43	54	nC
Gate Charge at 10V	Q _{g(10)}	V _{GS} = 0V to 10V		-	23	29	nC
Threshold Gate Charge	Q _{g(TH)}	V _{GS} = 0V to 2V		-	1.5	1.9	nC
Gate to Source Gate Charge	Q _{gs}			-	3.4	-	nC
Gate to Drain "Miller" Charge	Q _{gd}			-	8.8	-	nC
CAPACITANCE SPECIFICATIONS							
Input Capacitance	C _{ISS}	V _{DS} = 25V, V _{GS} = 0V, f = 1MHz (Figure 12)	-	800	-	pF	
Output Capacitance	C _{OSS}		-	180	-	pF	
Reverse Transfer Capacitance	C _{RSS}		-	65	-	pF	

Source to Drain Diode Specifications

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNITS
Source to Drain Diode Voltage	V_{SD}	$I_{SD} = 14\text{A}$	-	-	1.25	V
		$I_{SD} = 7\text{A}$	-	-	1.00	V
Reverse Recovery Time	t_{rr}	$I_{SD} = 14\text{A}$, $dI_{SD}/dt = 100\text{A}/\mu\text{s}$	-	-	150	ns
Reverse Recovered Charge	Q_{RR}	$I_{SD} = 14\text{A}$, $dI_{SD}/dt = 100\text{A}/\mu\text{s}$	-	-	750	nC

Typical Performance Curves

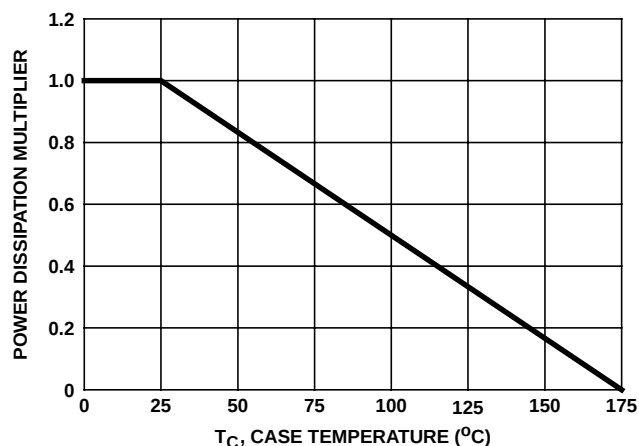


FIGURE 1. NORMALIZED POWER DISSIPATION vs CASE TEMPERATURE

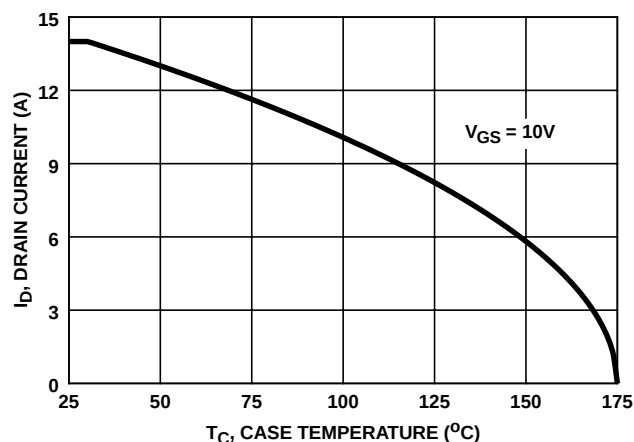


FIGURE 2. MAXIMUM CONTINUOUS DRAIN CURRENT vs CASE TEMPERATURE

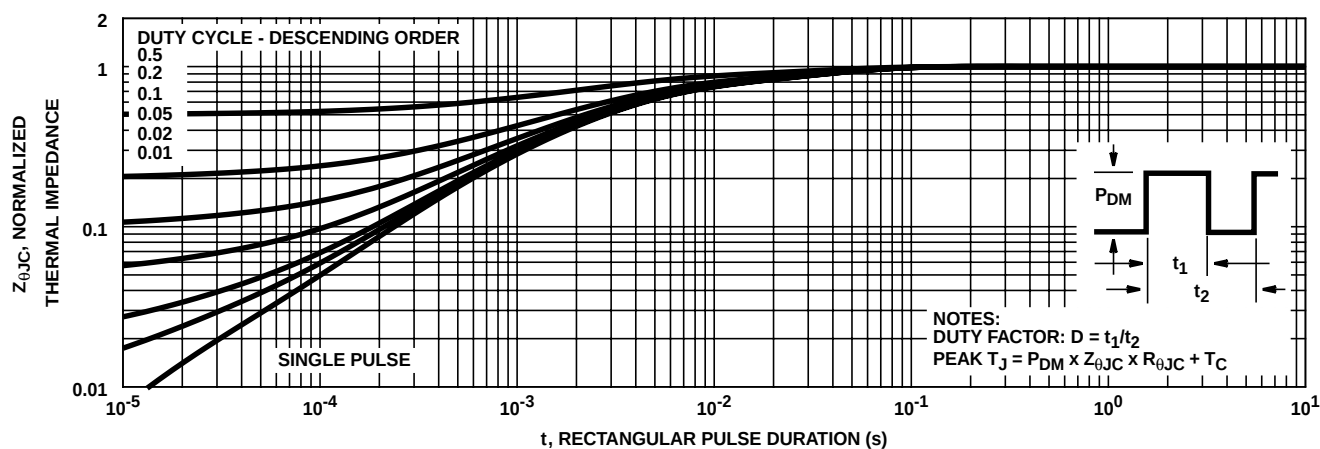


FIGURE 3. NORMALIZED MAXIMUM TRANSIENT THERMAL IMPEDANCE

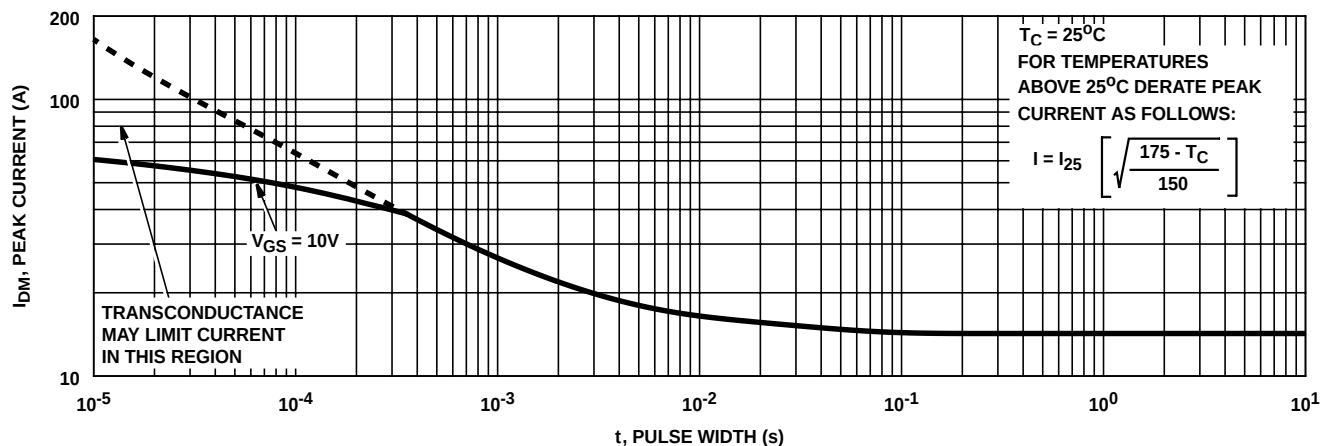


FIGURE 4. PEAK CURRENT CAPABILITY

Typical Performance Curves (Continued)

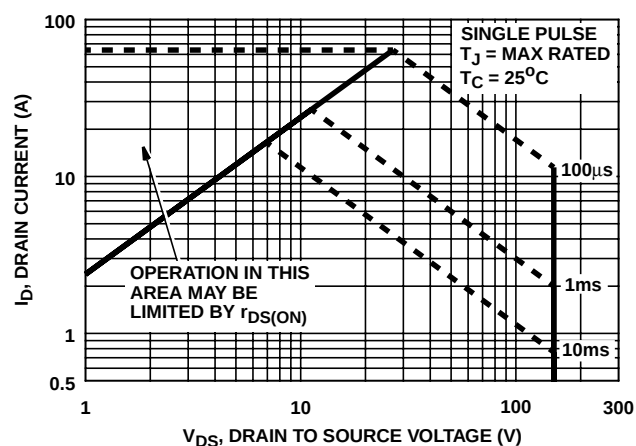
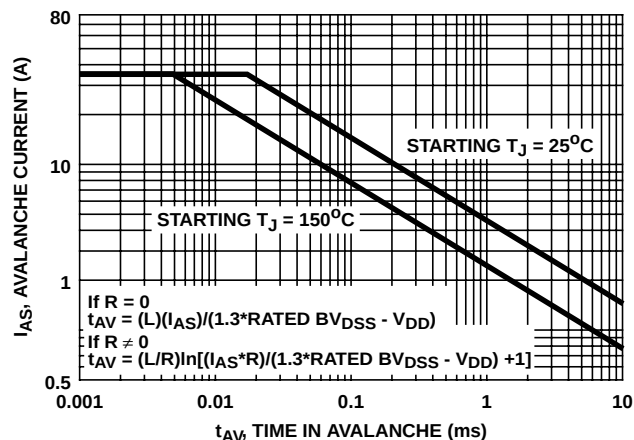


FIGURE 5. FORWARD BIAS SAFE OPERATING AREA



NOTE: Refer to Intersil Application Notes AN9321 and AN9322.

FIGURE 6. UNCLAMPED INDUCTIVE SWITCHING CAPABILITY

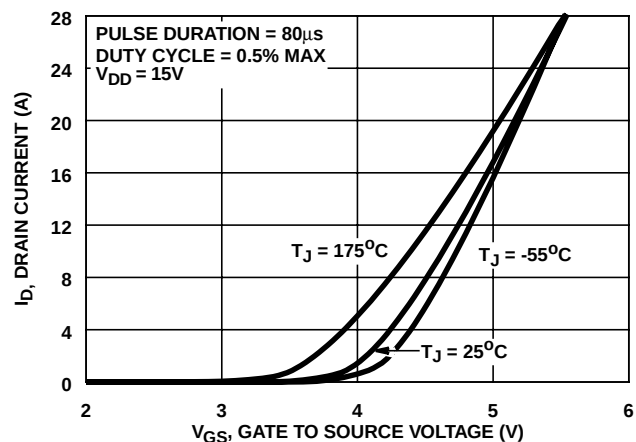


FIGURE 7. TRANSFER CHARACTERISTICS

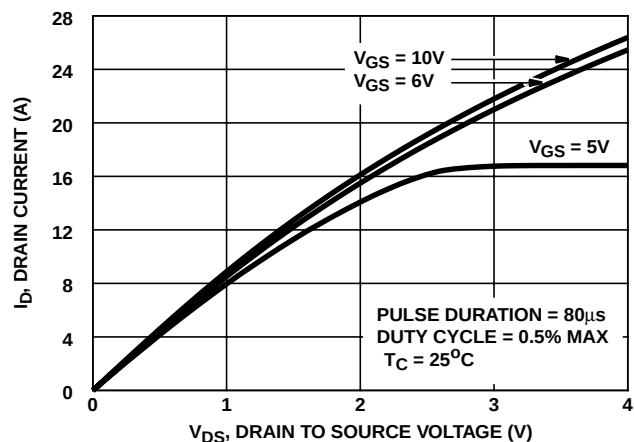


FIGURE 8. SATURATION CHARACTERISTICS

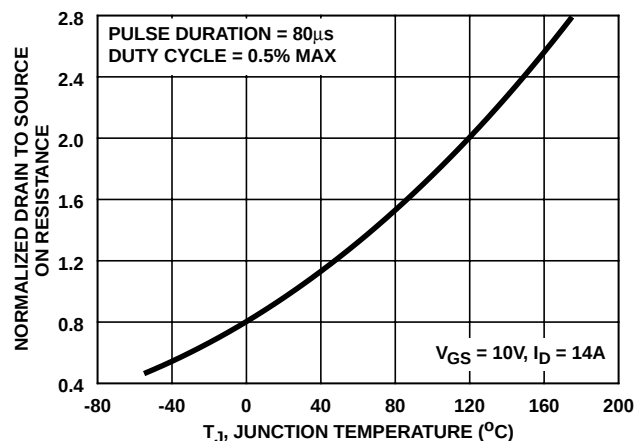


FIGURE 9. NORMALIZED DRAIN TO SOURCE ON RESISTANCE vs JUNCTION TEMPERATURE

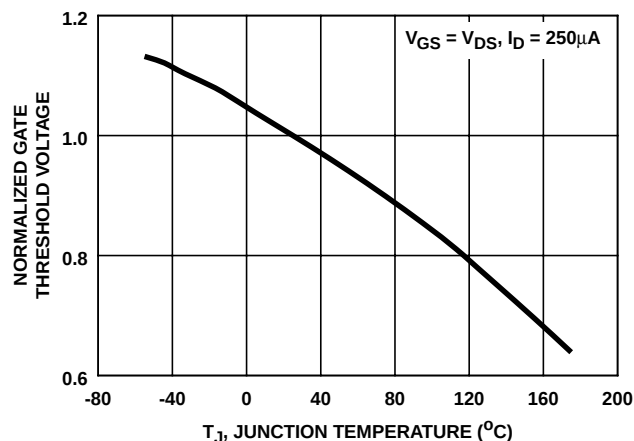


FIGURE 10. NORMALIZED GATE THRESHOLD VOLTAGE vs JUNCTION TEMPERATURE

Typical Performance Curves (Continued)

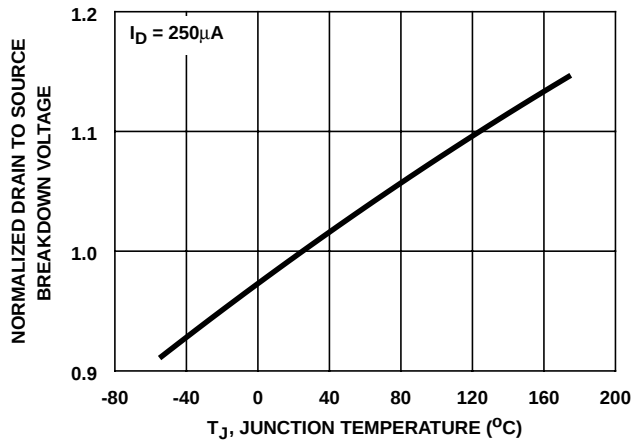


FIGURE 11. NORMALIZED DRAIN TO SOURCE BREAKDOWN VOLTAGE vs JUNCTION TEMPERATURE

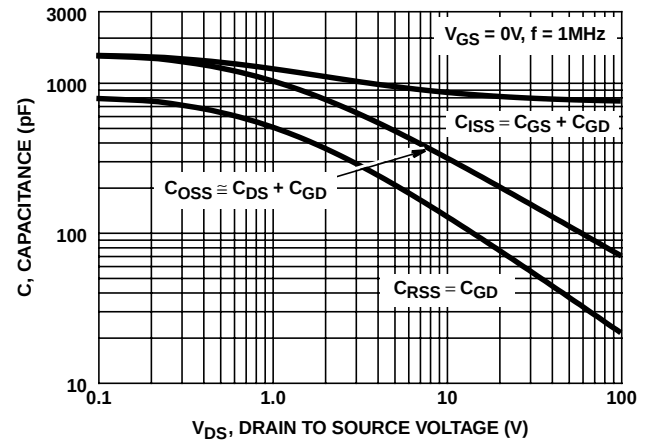
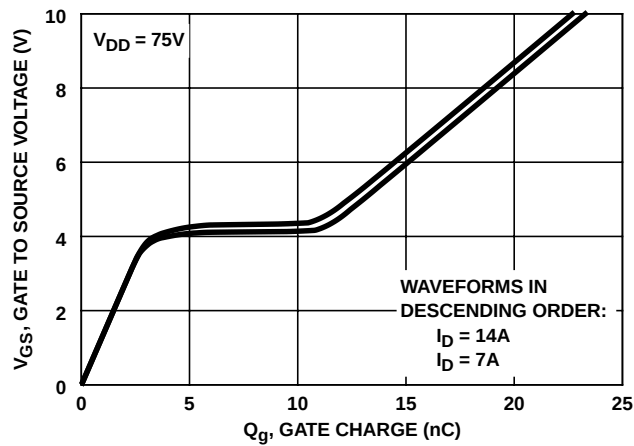


FIGURE 12. CAPACITANCE vs DRAIN TO SOURCE VOLTAGE



NOTE: Refer to Intersil Application Notes AN7254 and AN7260.

FIGURE 13. GATE CHARGE WAVEFORMS FOR CONSTANT GATE CURRENT

Test Circuits and Waveforms

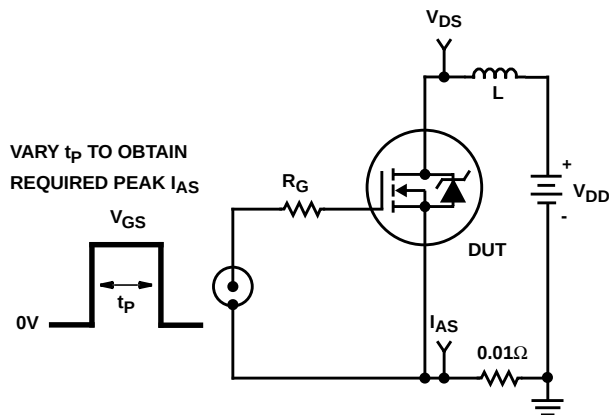


FIGURE 14. UNCLAMPED ENERGY TEST CIRCUIT

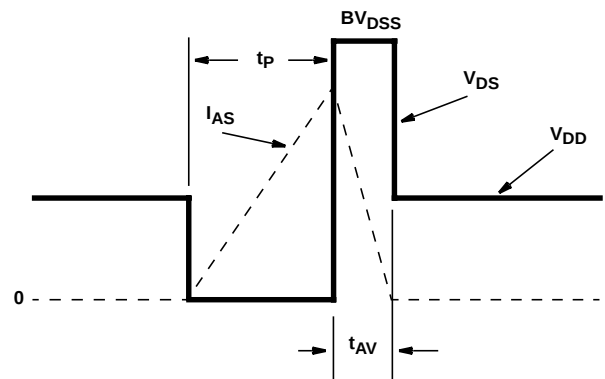


FIGURE 15. UNCLAMPED ENERGY WAVEFORMS

Test Circuits and Waveforms (Continued)

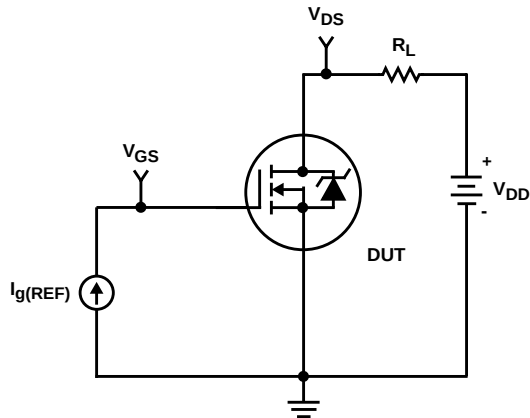


FIGURE 16. GATE CHARGE TEST CIRCUIT

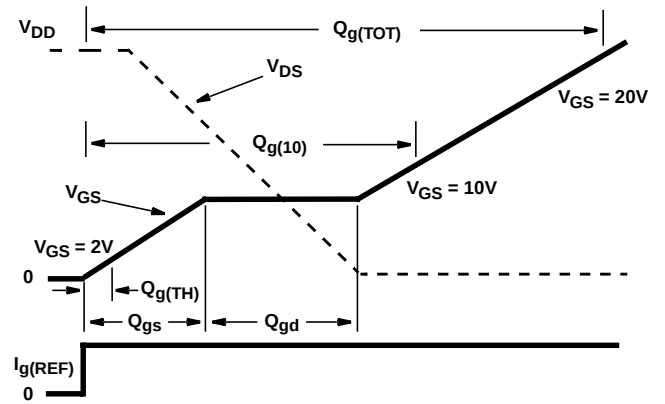


FIGURE 17. GATE CHARGE WAVEFORMS

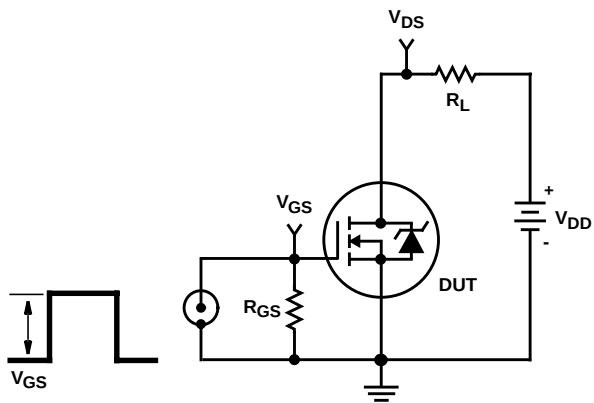


FIGURE 18. SWITCHING TIME TEST CIRCUIT

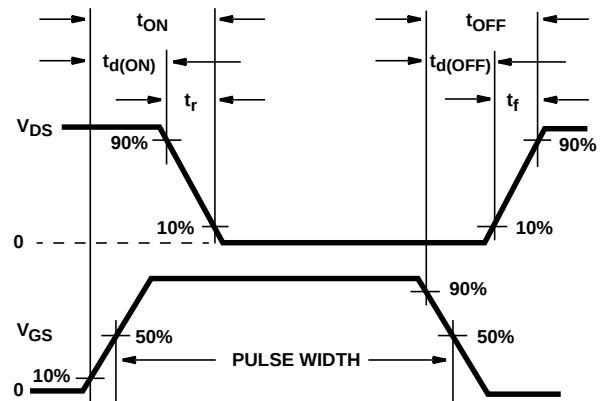


FIGURE 19. SWITCHING TIME WAVEFORM

SPICE Thermal Model

REV 25 October 1999

HUF75823D

CTHERM1 th 6 1.40e-3
 CHERM2 6 5 5.55e-3
 CHERM3 5 4 5.65e-3
 CHERM4 4 3 6.10e-3
 CHERM5 3 2 9.80e-3
 CHERM6 2 tl 7.70e-2

RHERM1 th 6 1.10e-2
 RHERM2 6 5 5.80e-2
 RHERM3 5 4 1.35e-1
 RHERM4 4 3 3.60e-1
 RHERM5 3 2 4.13e-1
 RHERM6 2 tl 4.30e-1

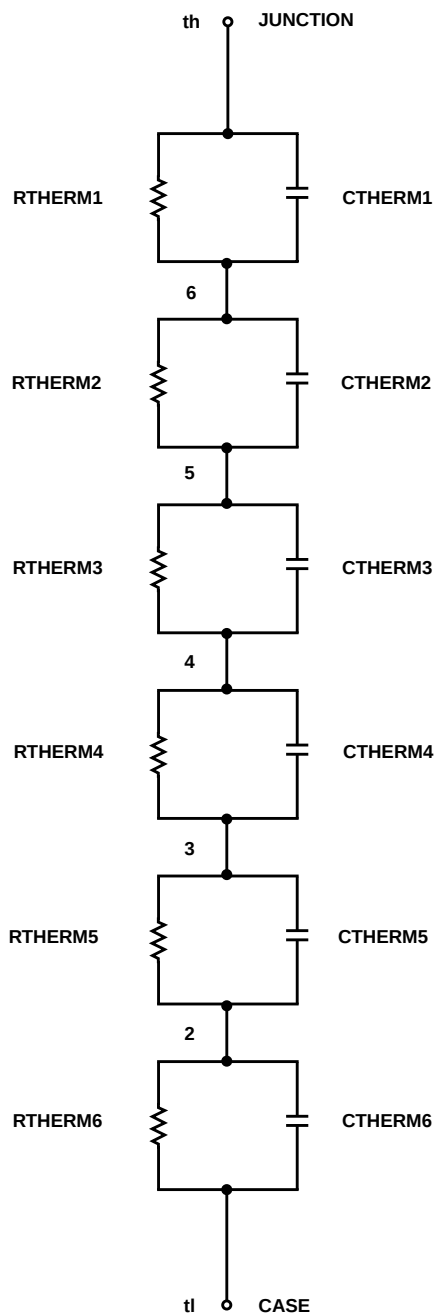
SABER Thermal Model

SABER thermal model HUF75823D

template thermal_model th tl
 thermal_c th, tl

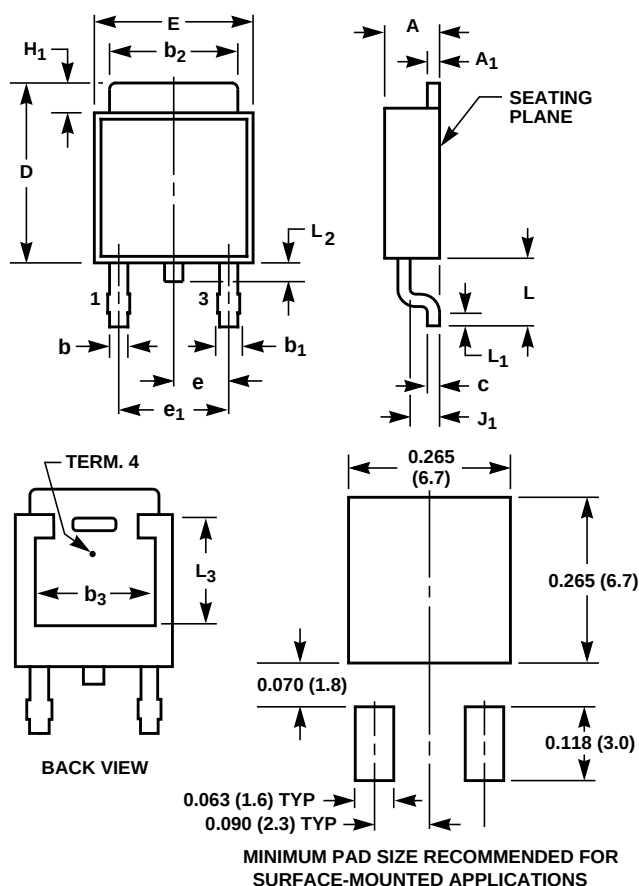
```
{
    ctherm.ctherm1 th 6 = 1.40e-3
    ctherm.ctherm2 6 5 = 5.55e-3
    ctherm.ctherm3 5 4 = 5.65e-3
    ctherm.ctherm4 4 3 = 6.10e-3
    ctherm.ctherm5 3 2 = 9.80e-3
    ctherm.ctherm6 2 tl = 7.70e-2
```

```
    rtherm.rtherm1 th 6 = 1.10e-2
    rtherm.rtherm2 6 5 = 5.80e-2
    rtherm.rtherm3 5 4 = 1.35e-1
    rtherm.rtherm4 4 3 = 3.60e-1
    rtherm.rtherm5 3 2 = 4.13e-1
    rtherm.rtherm6 2 tl = 4.30e-1
}
```



TO-252AA

SURFACE MOUNT JEDEC TO-252AA PLASTIC PACKAGE



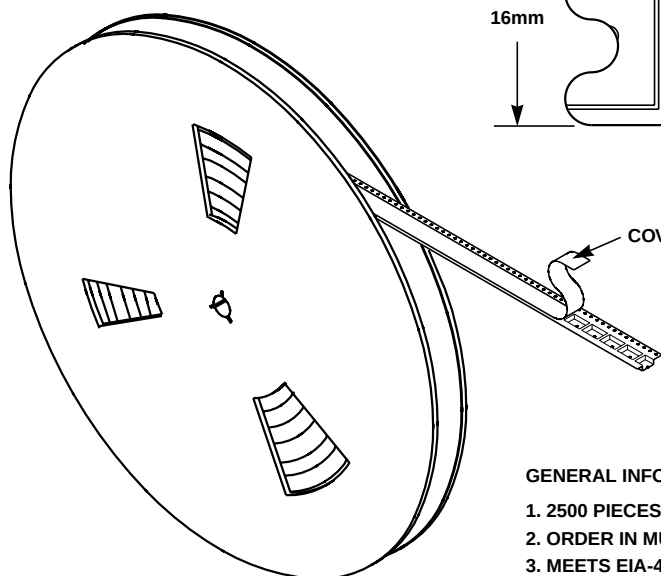
SYMBOL	INCHES		MILLIMETERS		NOTES
	MIN	MAX	MIN	MAX	
A	0.086	0.094	2.19	2.38	-
A ₁	0.018	0.022	0.46	0.55	4, 5
b	0.028	0.032	0.72	0.81	4, 5
b ₁	0.033	0.045	0.84	1.14	4
b ₂	0.205	0.215	5.21	5.46	4, 5
b ₃	0.190	-	4.83	-	2
c	0.018	0.022	0.46	0.55	4, 5
D	0.270	0.295	6.86	7.49	-
E	0.250	0.265	6.35	6.73	-
e	0.090 TYP		2.28 TYP		7
e ₁	0.180 BSC		4.57 BSC		7
H ₁	0.035	0.045	0.89	1.14	-
J ₁	0.040	0.045	1.02	1.14	-
L	0.100	0.115	2.54	2.92	-
L ₁	0.020	-	0.51	-	4, 6
L ₂	0.025	0.040	0.64	1.01	3
L ₃	0.170	-	4.32	-	2

NOTES:

- These dimensions are within allowable dimensions of Rev. B of JEDEC TO-252AA outline dated 9-88.
- L₃ and b₃ dimensions establish a minimum mounting surface for terminal 4.
- Solder finish uncontrolled in this area.
- Dimension (without solder).
- Add typically 0.002 inches (0.05mm) for solder plating.
- L₁ is the terminal length for soldering.
- Position of lead to be measured 0.090 inches (2.28mm) from bottom of dimension D.
- Controlling dimension: Inch.
- Revision 11 dated 1-00.

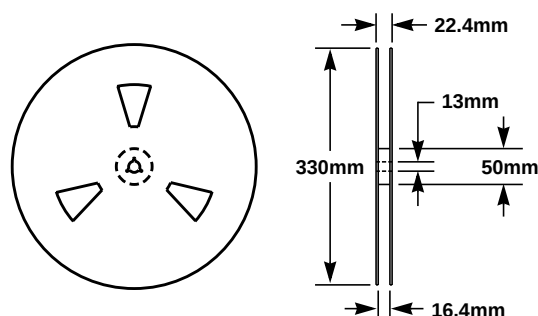
TO-252AA

16mm TAPE AND REEL



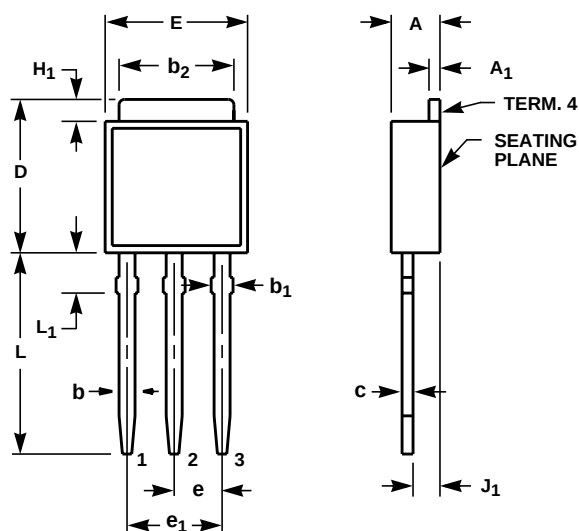
GENERAL INFORMATION

- 2500 PIECES PER REEL.
- ORDER IN MULTIPLES OF FULL REELS ONLY.
- MEETS EIA-481 REVISION "A" SPECIFICATIONS.



TO-251AA

3 LEAD JEDEC TO-251AA PLASTIC PACKAGE



SYMBOL	INCHES		MILLIMETERS		NOTES
	MIN	MAX	MIN	MAX	
A	0.086	0.094	2.19	2.38	-
A_1	0.018	0.022	0.46	0.55	3, 4
b	0.028	0.032	0.72	0.81	3, 4
b_1	0.033	0.045	0.84	1.14	3
b_2	0.205	0.215	5.21	5.46	3, 4
c	0.018	0.022	0.46	0.55	3, 4
D	0.270	0.295	6.86	7.49	-
E	0.250	0.265	6.35	6.73	-
e	0.090 TYP		2.28 TYP		5
e_1	0.180 BSC		4.57 BSC		5
H_1	0.035	0.045	0.89	1.14	-
J_1	0.040	0.045	1.02	1.14	6
L	0.355	0.375	9.02	9.52	-
L_1	0.075	0.090	1.91	2.28	2

NOTES:

1. These dimensions are within allowable dimensions of Rev. C of JEDEC TO-251AA outline dated 9-88.
2. Solder finish uncontrolled in this area.
3. Dimension (without solder).
4. Add typically 0.002 inches (0.05mm) for solder plating.
5. Position of lead to be measured 0.250 inches (6.35mm) from bottom of dimension D.
6. Position of lead to be measured 0.100 inches (2.54mm) from bottom of dimension D.
7. Controlling dimension: Inch.
8. Revision 3 dated 1-00.

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Sales Office Headquarters

NORTH AMERICA

Intersil Corporation
P. O. Box 883, Mail Stop 53-204
Melbourne, FL 32902
TEL: (321) 724-7000
FAX: (321) 724-7240

EUROPE

Intersil SA
Mercure Center
100, Rue de la Fusee
1130 Brussels, Belgium
TEL: (32) 2.724.2111
FAX: (32) 2.724.22.05

ASIA

Intersil (Taiwan) Ltd.
7F-6, No. 101 Fu Hsing North Road
Taipei, Taiwan
Republic of China
TEL: (886) 2 2716 9310
FAX: (886) 2 2715 3029